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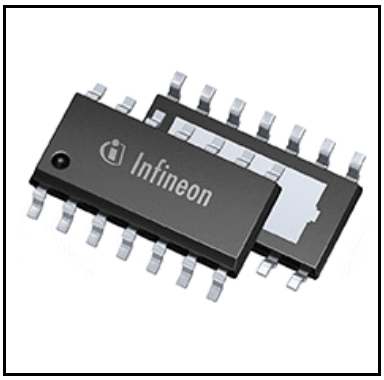
PROFET™+ 24V

BTF6070-2EKV

Smart High-Side Power Switch Dual Channel 60 mΩ

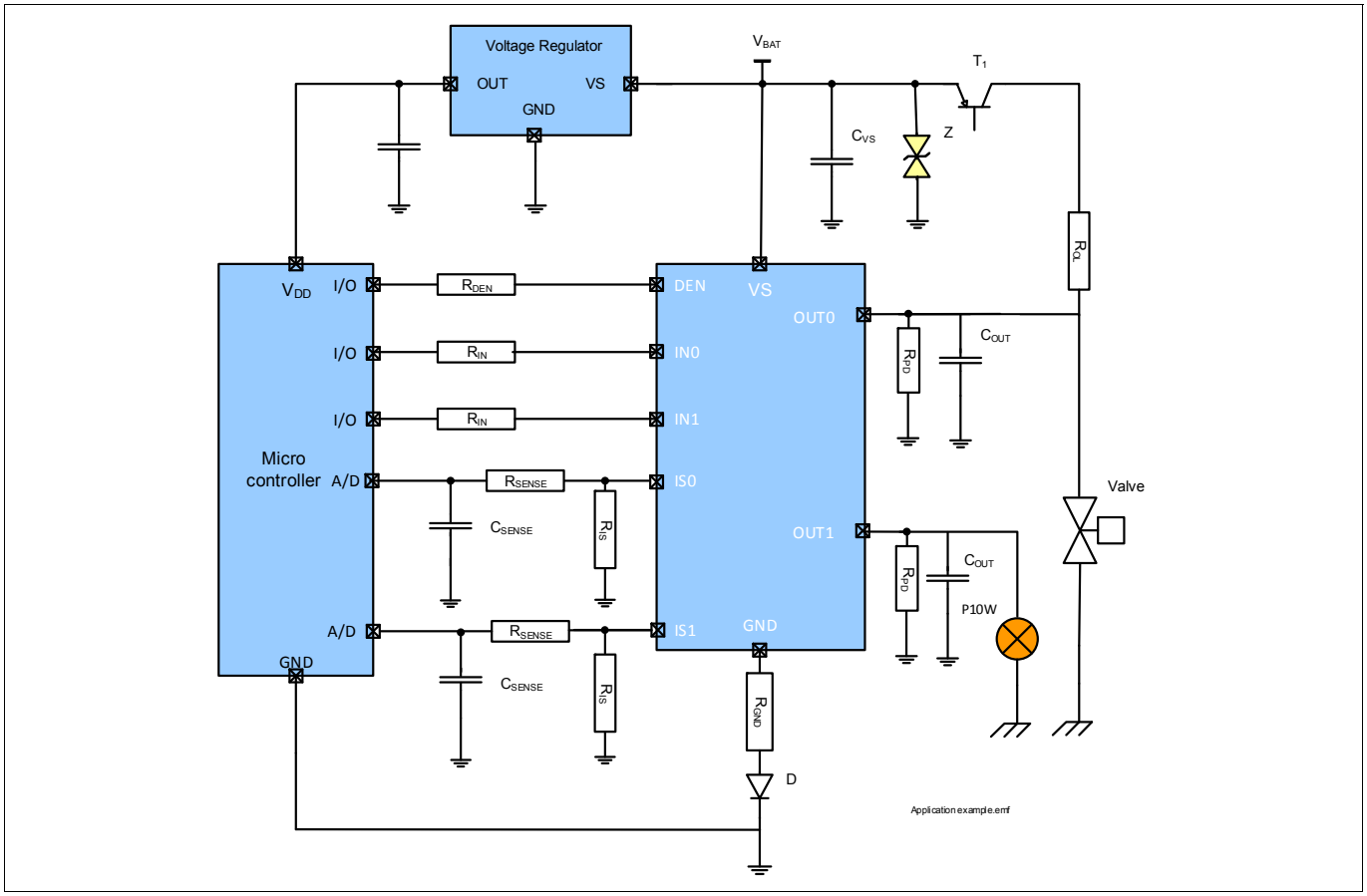
Package	PG-DSO-14-40 EP
Marking	BTF6070-2EKV



1 Overview

Application

- Suitable for 24 V Trucks and Transportation Systems
- Specially designed to drive Valve Applications
- Can be used for PWM frequencies up to 1.5 kHz
- Suitable for resistive, inductive and capacitive loads
- Replaces electromechanical relays, fuses and discrete circuits



Application Diagram with BTF6070-2EKV

Overview

Basic Features

- Dual channel device
- Fast switching device
- For 12 V and 24 V grounded loads
- Very low stand-by current
- 3.3 V and 5 V compatible logic inputs
- Electrostatic discharge protection (ESD)
- Optimized electromagnetic compatibility
- Logic ground independent from load ground
- Very low power DMOS leakage current in OFF state
- Green product (RoHS compliant)
- AEC qualified

Description

The BTF6070-2EKV is a 60 mΩ dual channel Smart High-Side Power Switch, embedded in a PG-DSO-14-40 EP, Exposed Pad package, providing protective functions and diagnosis. The power transistor is built by an N-channel vertical power MOSFET with charge pump. The device is integrated in Smart6 HV technology. It is specially designed to drive Valve Applications in the harsh automotive environment. For lighting applications the nominal bulb load of P10W+P5W 24 V or P10W 12 V is considered.

Table 1 Product Summary

Parameter	Symbol	Value
Operating voltage range	$V_{S(OP)}$	5 V ... 36 V
Maximum supply voltage	$V_{S(LD)}$	65 V
Maximum ON state resistance at T_J = 150 °C per channel	$R_{DS(ON)}$	135 mΩ
Nominal load current (one channel active)	$I_{L(NOM)1}$	3 A
Nominal load current (all channels active)	$I_{L(NOM)2}$	2.3 A
Typical current sense ratio	k_{ILIS}	1730
Minimum current limitation	$I_{L5(SC)}$	9 A
Maximum standby current with load at T_J = 25 °C	$I_{S(OFF)}$	500 nA

Diagnostic Functions

- Proportional load current sense for the 2 channels
- Open load detection in ON and OFF
- Short circuit to battery and ground indication
- Overtemperature switch off detection
- Stable diagnostic signal during short circuit
- Enhanced k_{ILIS} dependency with temperature and load current

Overview

Protection Functions

- Stable behavior during undervoltage
- Reverse polarity protection with external components
- Secure load turn-off during logic ground disconnection with external components
- Overtemperature protection with latch
- Overvoltage protection with external components
- Enhanced short circuit operation

Table of Contents

2 Block Diagram

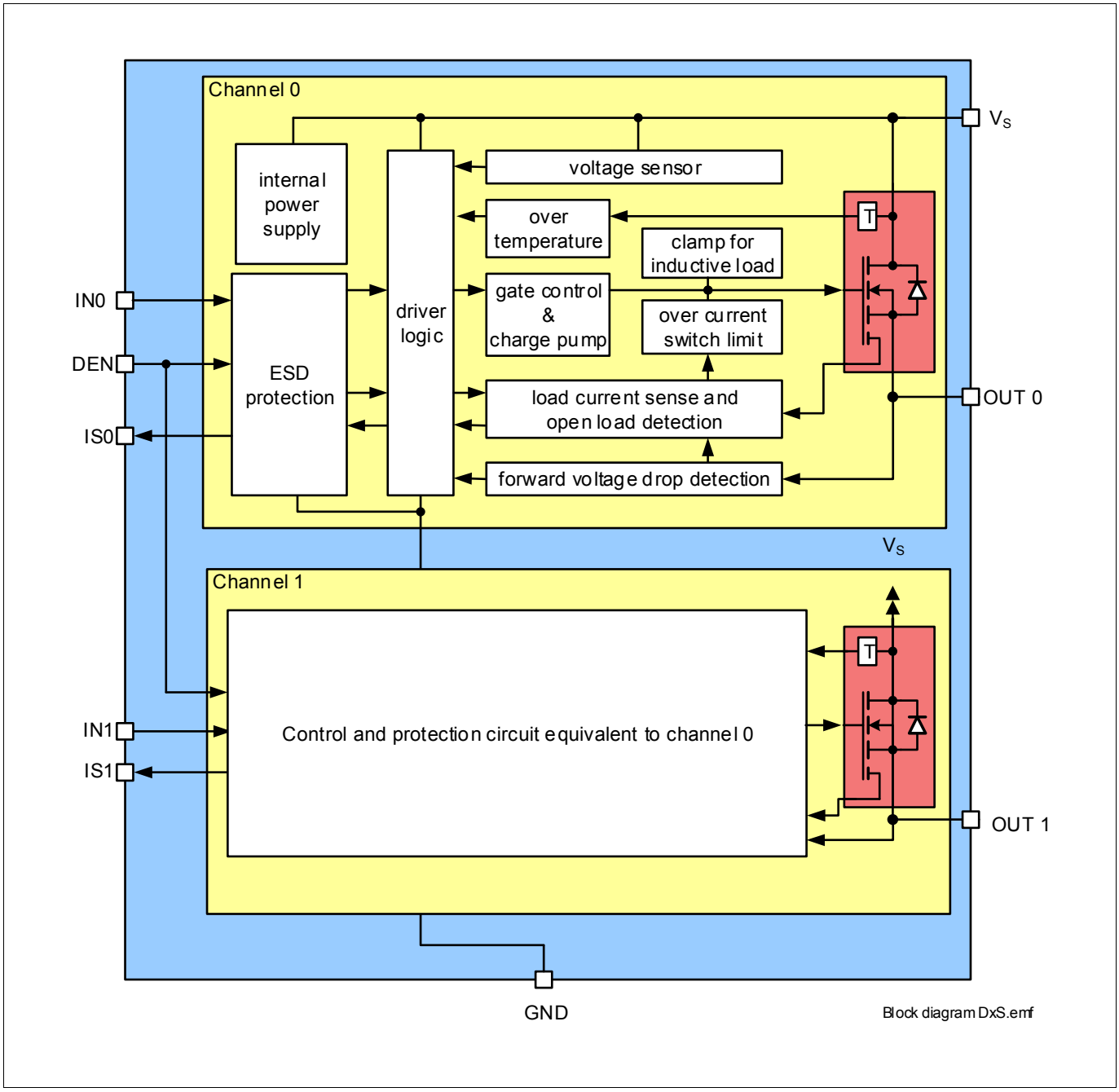


Figure 1 Block Diagram for the BTF6070-2EKV

3 Pin Configuration

3.1 Pin Assignment

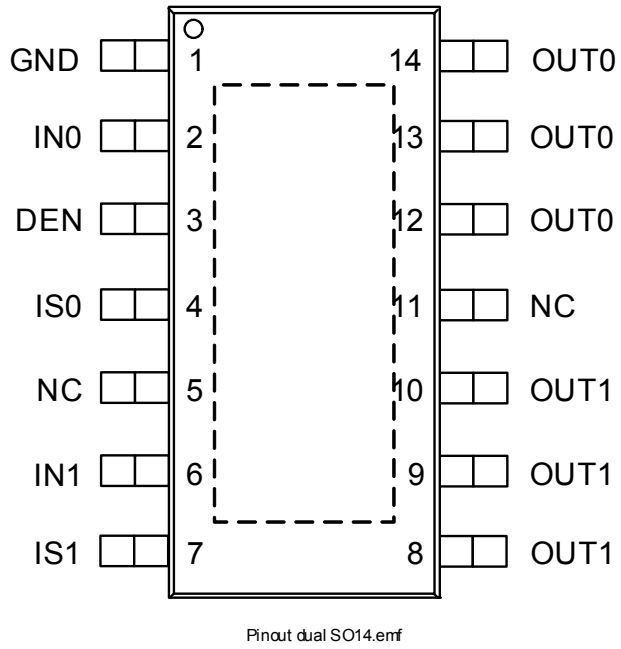


Figure 2 Pin Configuration

3.2 Pin Definitions and Functions

Table 2 Pin Definition and Functions

Pin	Symbol	Function
1	GND	**GrouND;** Ground connection
2	IN0	**INput channel 0;** Input signal for channel 0 activation
3	DEN	**Diagnostic ENable;** Digital signal to enable/disable the diagnosis of the device
4	IS0	**Sense 0;** Sense current of the channel 0
5, 11	NC	**Not Connected;** No internal connection to the chip
6	IN1	**INput channel 1;** Input signal for channel 1 activation
7	IS1	**Sense 1;** Sense current of the channel 1
8, 9, 10	OUT1	**OUTput 1;** Protected high side power output channel 1[1)]
12, 13, 14	OUT0	**OUTput 0;** Protected high side power output channel 0[1)]
Cooling Tab	V_S	**Voltage Supply;** Battery voltage

1) All output pins of a given channel must be connected together on the PCB. All pins of an output are internally connected together. PCB traces have to be designed to withstand the maximum current which can flow.

3.3 Voltage and Current Definition

Figure 3 shows all terms used in this data sheet, with associated convention for positive values.

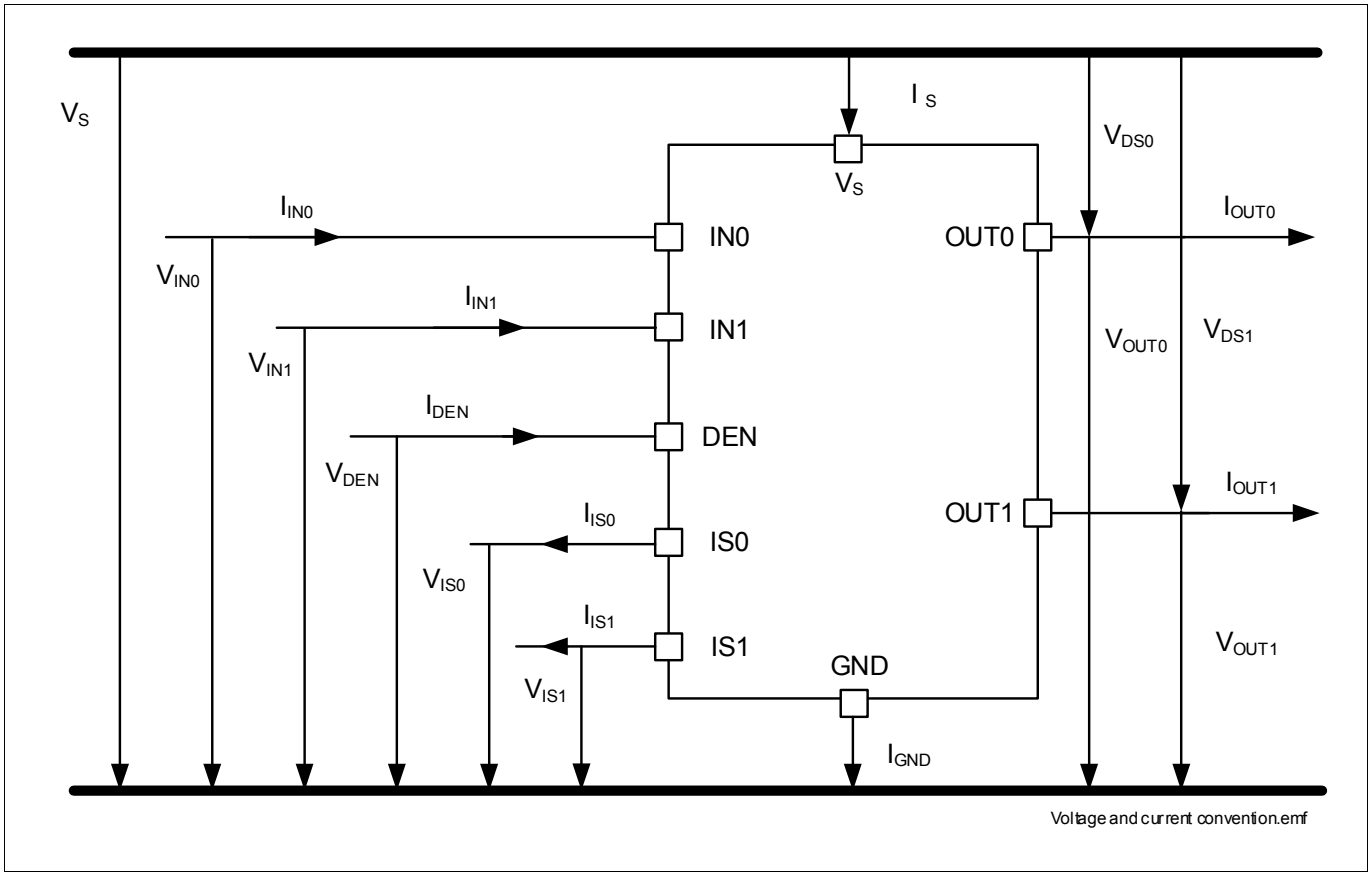


Figure 3 Voltage and Current Definition

4 General Product Characteristics

4.1 Absolute Maximum Ratings

Table 3 Absolute Maximum Ratings [1)]

T_J = -40°C to 150°C; (unless otherwise specified)

Parameter	Symbol	Values			Unit	Note or Test Condition	Number
		Min.	Typ.	Max.			
Supply Voltages							
Supply voltage	V_S	-0.3	-	48	V	-	P_4.1.1
Reverse polarity voltage	$-V_{S(REV)}$	0	-	28	V	t < 2 min T_A = 25 °C R_L ≥ 25 Ω	P_4.1.2
Supply voltage for short circuit protection	$V_{BAT(SC)}$	0	-	36	V	R_{ECU} = 30 mΩ R_{Supply} = 10 mΩ L_{Supply} = 5 µH R_{Cable}= 7 mΩ/m L_{Cable}= 1 µH/m, l = 0 to 40 m See Chapter 6 and Figure 29	P_4.1.3
Supply voltage for Load dump protection	$V_{S(LD)}$	-	-	65	V	[2)] R_I = 2 Ω R_L = 25 Ω	P_4.1.12
Short Circuit Capability							
Permanent short circuit IN pin toggles	n_{RSC1}	-	-	100	k cycles	[3)] V_{Supply} = 28 V R_{ECU} = 20 mΩ R_{Supply} = 10 mΩ L_{Supply}= 5 µH R_{Cable} = 0 mΩ L_{Cable} = <1 µH	P_4.1.4
Permanent short circuit IN pin toggles	n_{RSC_highL}	-	-	100	k cycles	[3)] V_{Supply} = 28 V R_{ECU} = 30 mΩ R_{Supply} = 10 mΩ L_{Supply} = 5 µH RCable = 280 mΩ L_{Cable} = 40 µH	P_4.1.5
Input Pins							
Voltage at INPUT pins	V_{IN}	-0.3	-	6	V	-	P_4.1.13
Voltage at INPUT pins	V_{IN}	-	-	7	V	t < 2 min	P_4.1.6
Current through INPUT pins	I_{IN}	-2	-	2	mA	-	P_4.1.14
Voltage at DEN pin	V_{DEN}	-0.3	-	6	V	-	P_4.1.15
Voltage at DEN pin	V_{DEN}	-		7	V	t < 2 min	P_4.1.50

Table 3 Absolute Maximum Ratings (cont'd)[1)]

T_J = -40°C to 150°C; (unless otherwise specified)

Parameter	Symbol	Values			Unit	Note or Test Condition	Number
		Min.	Typ.	Max.			
Current through DEN pin	I_{DEN}	-2	-	2	mA	-	P_4.1.16
Sense Pin							
Voltage at IS pin	V_{IS}	-0.3	-	V_S	V	-	P_4.1.19
Current through IS pin	I_{IS}	-25	-	50	mA	-	P_4.1.20
Power Stage							
Load current	$\lvert I_L \rvert$	-	-	$I_{L(LIM)}$	A	-	P_4.1.21
Power dissipation (DC)	P_{TOT}	-	-	1.8	W	T_A = 85 °C T_J < 150 °C	P_4.1.22
Maximum energy dissipation repetitive pulse (one channel)	E_{AR_2A}	-	-	40	mJ	20 Mio. cycles $I_{L(0)}$ = 2 A $T_{J(0)}$ = 105 °C	P_4.1.24
Negative voltage slope at output (inductive clamping)	$-dV_{OUT}/dt$	-	-	-20	V/µs	1) V_{OUT} = 28 V to 28 V-$V_{DS(AZ)}$ V_{IN} = 0 V	P_4.1.35
Positive voltage slope at output	dV_{OUT}/dt	-	-	20	V/µs	1) V_{OUT} = 0 V to 28 V V_{IN} = 0 V	P_4.1.36
Voltage at power transistor	V_{DS}	-	-	65	V	-	P_4.1.26
Currents							
Current through ground pin	I_{GND}	-20	-	20	mA	-	P_4.1.27
Current through ground pin	I_{GND}	-150	-	20	mA	t < 2 min	P_4.1.7
Temperatures							
Junction temperature	T_J	-40	-	150	°C	-	P_4.1.28
Storage temperature	T_{STG}	-55	-	150	°C	-	P_4.1.30
ESD Susceptibility							
ESD susceptibility (all pins)	V_{ESD}	-2	-	2	kV	4) HBM	P_4.1.31
ESD susceptibility OUT Pin vs. GND and V_S connected	V_{ESD}	-5	-	5	kV	4) HBM	P_4.1.32
ESD susceptibility	V_{ESD}	-500	-	500	V	5) CDM	P_4.1.33
ESD susceptibility pin (corner pins)	V_{ESD}	-750	-	750	V	5) CDM	P_4.1.34

1) Not subject to production test. Specified by design.
2) VS(LD) is setup without the DUT connected to the generator per ISO 7637-1.
3) Threshold limit for short circuit failures: 100 ppm. Please refer to the legal disclaimer for short-circuit capability at the end of this document.
4) ESD susceptibility HBM according to ANSI/ESDA/JEDEC JS-001.
5) "CDM" ESDA STM5.3.1 or ANSI/ESD 5.5.3.1

Notes

1. *Stresses above the ones listed here may cause permanent damage to the device. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.*
2. *Integrated protection functions are designed to prevent IC destruction under fault conditions described in the data sheet. Fault conditions are considered as "outside" normal operating range. Protection functions are not designed for continuous repetitive operation.*

4.2 Functional Range

Table 4 Functional Range T_J = -40°C to 150°C; (unless otherwise specified)

Parameter	Symbol	Values			Unit	Note or Test Condition	Number
		Min.	Typ.	Max.			
Nominal operating voltage	V_{NOM}	8	28	36	V	-	P_4.2.1
Extended operating voltage	$V_{S(OP)}$	5	-	48	V	1)3) V_{IN} = 4.5 V R_L = 25 Ω V_{DS} < 0.5 V	P_4.2.2
Minimum functional supply voltage	$V_{S(OP)\_MIN}$	3.8	4.3	5	V	2) V_{IN} = 4.5 V R_L = 25 Ω From I_{OUT} = 0 A to V_{DS} < 0.5 V; see Figure 16	P_4.2.3
Undervoltage shutdown	$V_{S(UV)}$	3	3.5	4.1	V	2) V_{IN} = 4.5 V V_{DEN} = 0 V R_L = 25 Ω From V_{DS} < 1 V to I_{OUT} = 0 A See Figure 16	P_4.2.4
Undervoltage shutdown hysteresis	$V_{S(UV)\_HYS}$	-	850	-	mV	3) -	P_4.2.13
Operating current One channel active	I_{GND_1}	-	5	7	mA	V_{IN} = 5.5 V V_{DEN} = 5.5 V Device in $R_{DS(ON)}$ V_S = 36 V	P_4.2.5
Operating current All channels active	I_{GND_2}	-	8.3	12	mA	V_{IN} = 5.5 V V_{DEN} = 5.5 V Device in $R_{DS(ON)}$ V_S = 36 V	P_4.2.6
Standby current for whole device with load (ambiente)	$I_{S(OFF)}$	-	0.1	0.5	µA	2) V_S = 36 V V_{OUT} = 0 V V_{IN} floating V_{DEN} floating $T_J \leq$ 85 °C	P_4.2.7

Table 4 Functional Range (cont'd)**T_J = -40°C to 150°C; (unless otherwise specified)**

Parameter	Symbol	Values			Unit	Note or Test Condition	Number
		Min.	Typ.	Max.			
Maximum standby current for whole device with load	$I_{S(OFF)\_150}$	-	-	10	µA	V_S = 36 V V_{OUT} = 0 V V_{IN} floating V_{DEN} floating T_J = 150 °C	P_4.2.10
Standby current for whole device with load, diagnostic active	$I_{S(OFF\_DEN)}$	-	1.15	-	mA	3) V_S = 36 V V_{OUT} = 0 V V_{IN} floating V_{DEN} = 5.5 V	P_4.2.8

1) Parameter deviation possible: R_{DSON}, $I_{IS(FAULT)}$ & timing parameters. Protection functions are working.
2) Test at T_J = -40°C only
3) Not subject to production test. Specified by design.

Note: Within the functional range the IC operates as described in the circuit description. The electrical characteristics are specified within the conditions given in the related electrical characteristics table.

4.3 Thermal Resistance

Table 5 Thermal Resistance

Parameter	Symbol	Values			Unit	Note or Test Condition	Number
		Min.	Typ.	Max.			
Junction to soldering point	R_{thJS}	-	3	-	K/W	1)	P_4.3.1
Junction to ambient All channels active	R_{thJA}	-	29	-	K/W	1)2)	P_4.3.2

1) Not subject to production test. Specified by design.
2) Specified R_{thja} value is according to JEDEC JESD51-2,-5,-7 at natural convection on FR4 2s2p board; The product (chip + package) was simulated on a 76.4 x 114.3 x 1.5 mm board with 2 inner copper layers (2 x 70µm Cu, 2 x 35 µm Cu). Where applicable, a thermal via array under the exposed pad contacts the first inner copper layer. Please refer to **Figure 4**.

4.3.1 PCB set up

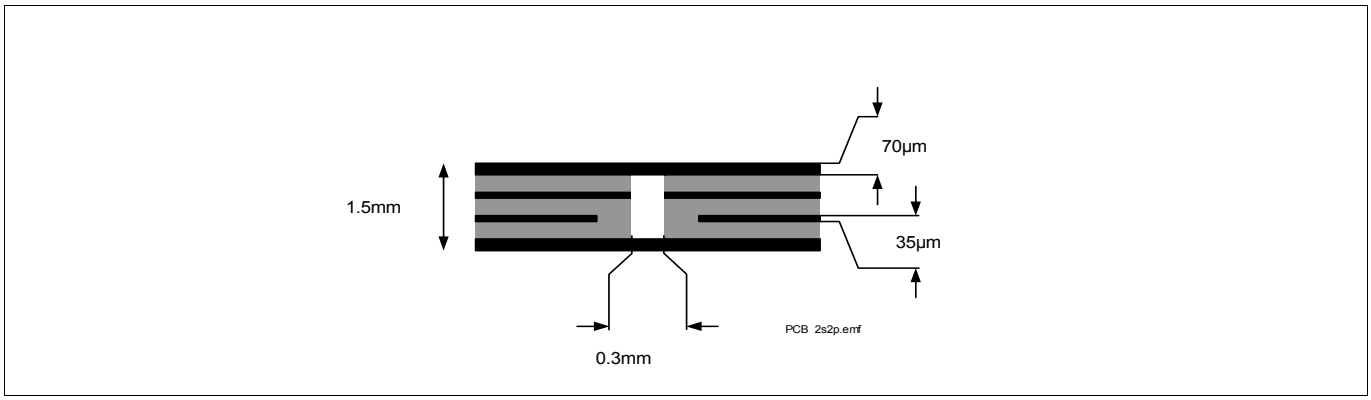


Figure 4 2s2p PCB Cross Section

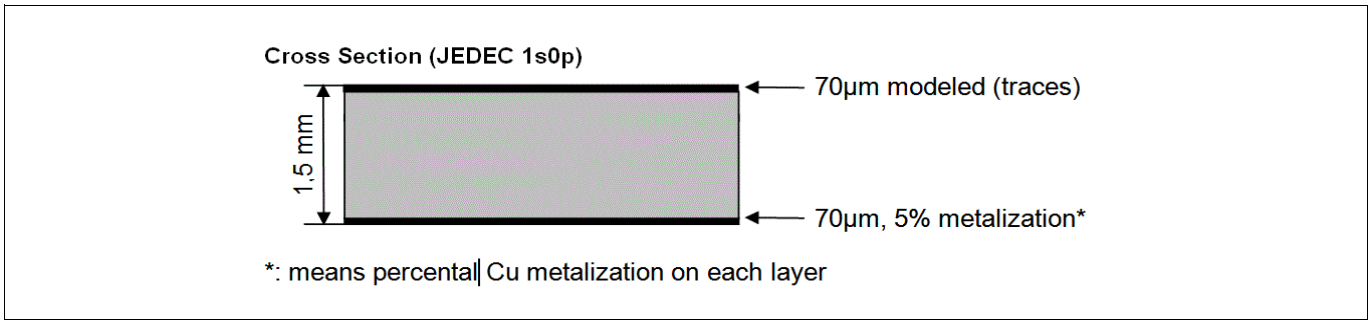


Figure 5 1s0p PCB Cross Section

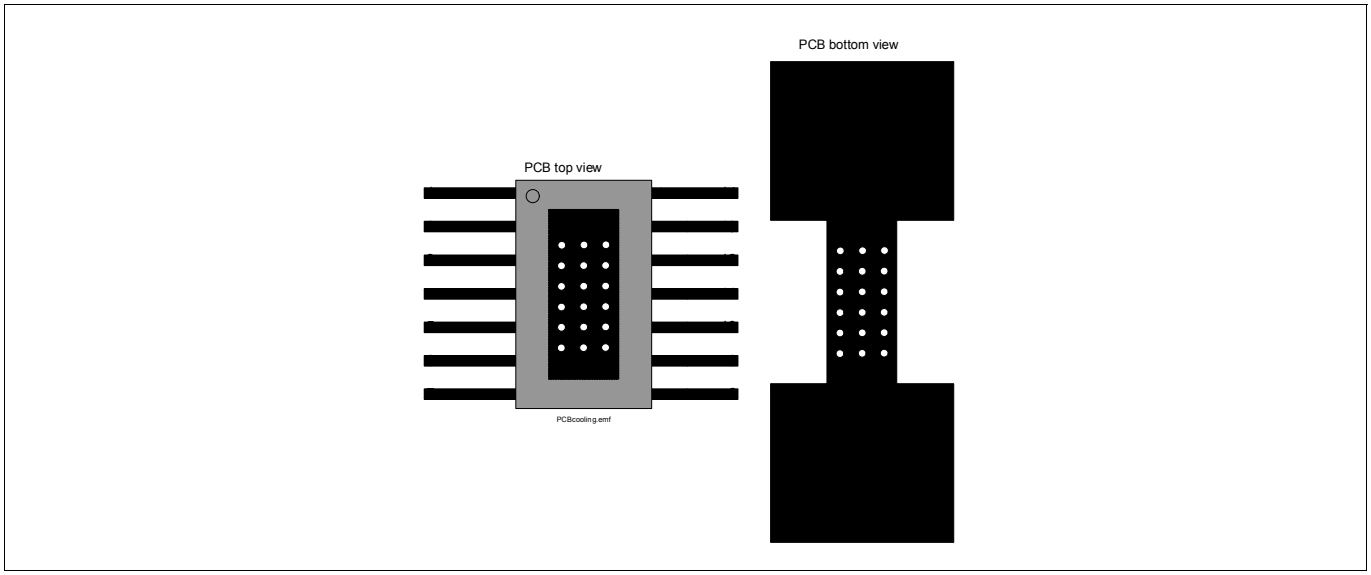


Figure 6 PC Board Top and Bottom View for Thermal Simulation with 600 mm² Cooling Area

4.3.2 Thermal Impedance

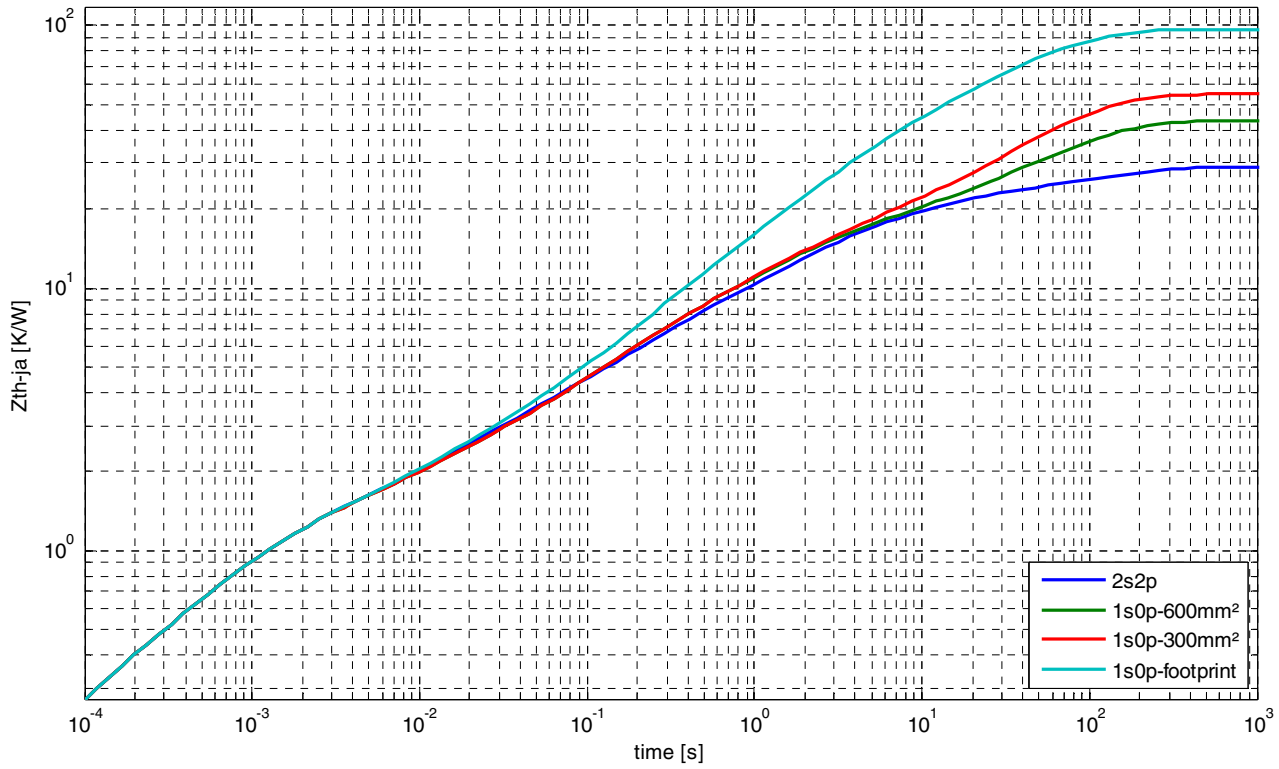


Figure 7 Typical Thermal Impedance. Both channels active. Ta=85°C. PCB set up according Figure 4 / Figure 5

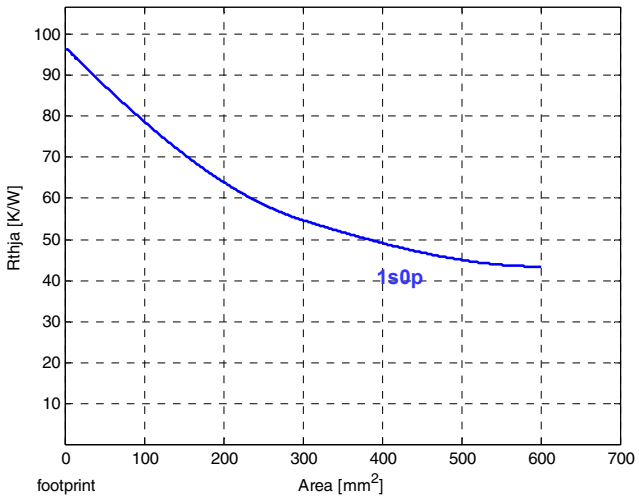


Figure 8 Typical Thermal Resistance. Both channels active. Ta=85°C. PCB set-up 1s0p

5 Power Stage

The power stages are built using an N-channel vertical power MOSFET (DMOS) with charge pump.

5.1 Output ON-State Resistance

The ON-state resistance $R_{DS(ON)}$ depends on the supply voltage as well as the junction temperature T_J. Figure 9 shows the dependencies in terms of temperature and supply voltage for the typical ON-state resistance. The behavior in reverse polarity is described in Chapter 6.4.

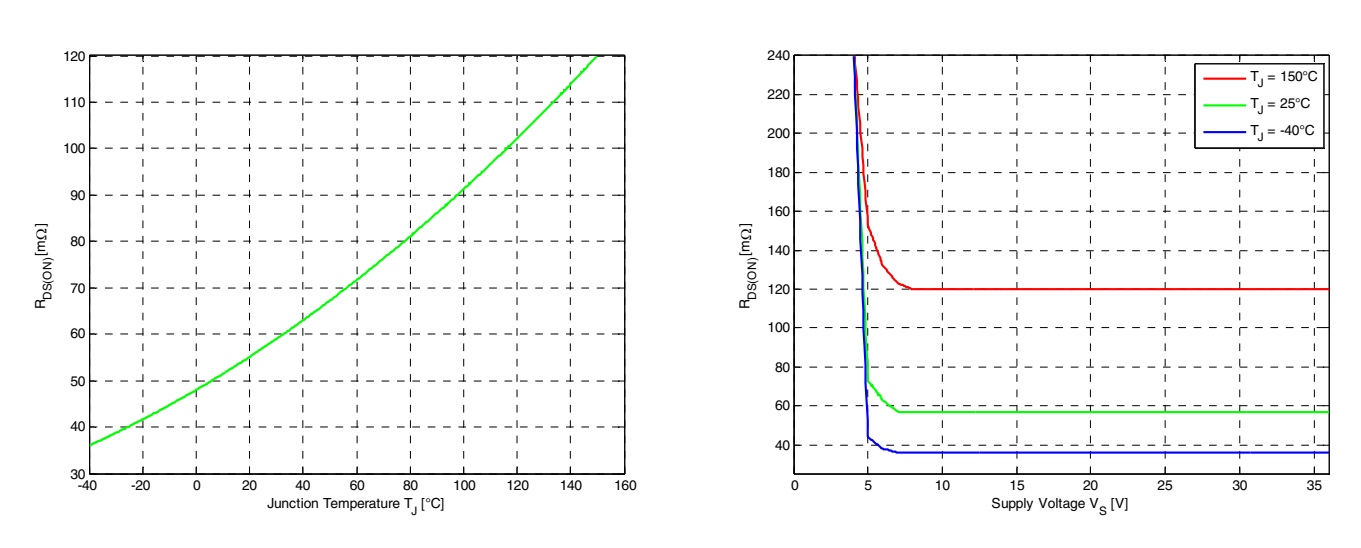


Figure 9 Typical ON-state Resistance

A high signal at the input pin (see Chapter 8) causes the power DMOS to switch ON with a dedicated slope, which is optimized in terms of EMC emission.

5.2 Turn ON/OFF Characteristics with Resistive Load

Figure 10 shows the typical timing when switching a resistive load.

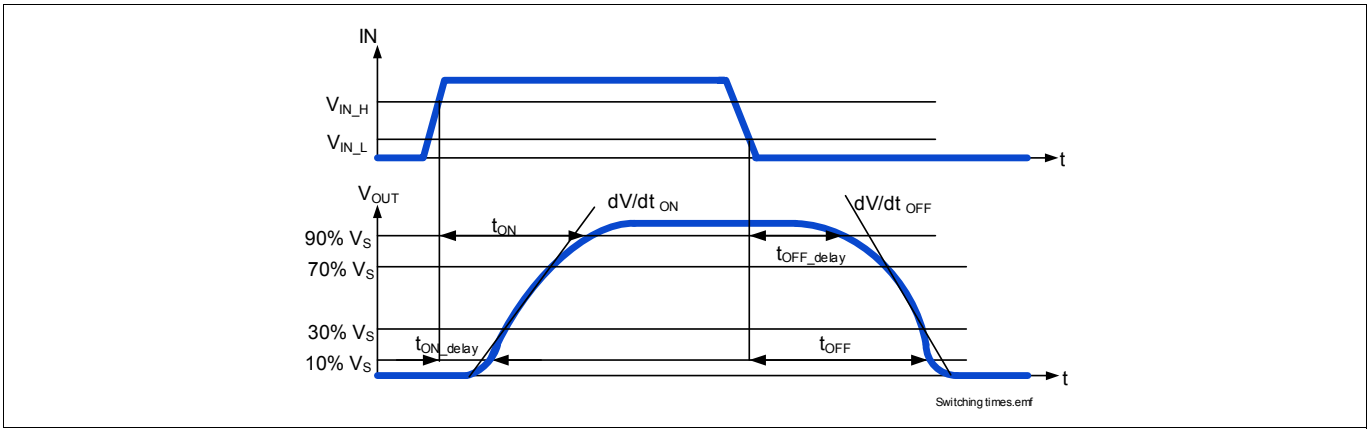


Figure 10 Switching a Resistive Load Timing

5.3 Inductive Load

5.3.1 Output Clamping

When switching OFF inductive loads with high side switches, the voltage V_{OUT} drops below ground potential, because the inductance intends to continue driving the current. To prevent the destruction of the device by avalanche due to high voltages, there is a voltage clamp mechanism $Z_{DS(AZ)}$ implemented that limits negative output voltage to a certain level (V_S - $V_{DS(AZ)}$). Please refer to Figure 11 and Figure 12 for details. Nevertheless, the maximum allowed load inductance is limited.

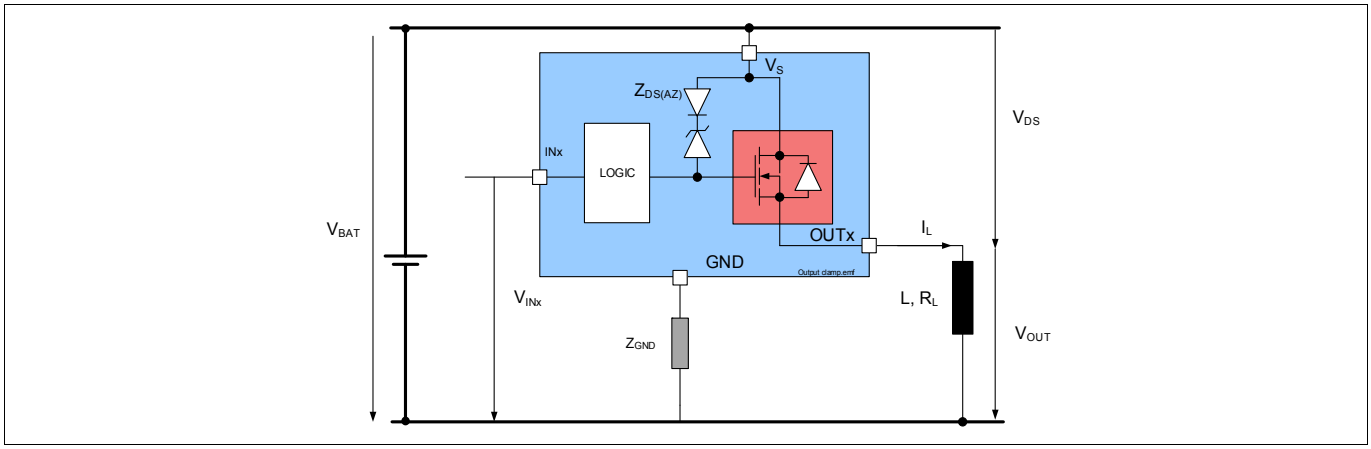


Figure 11 Output Clamp

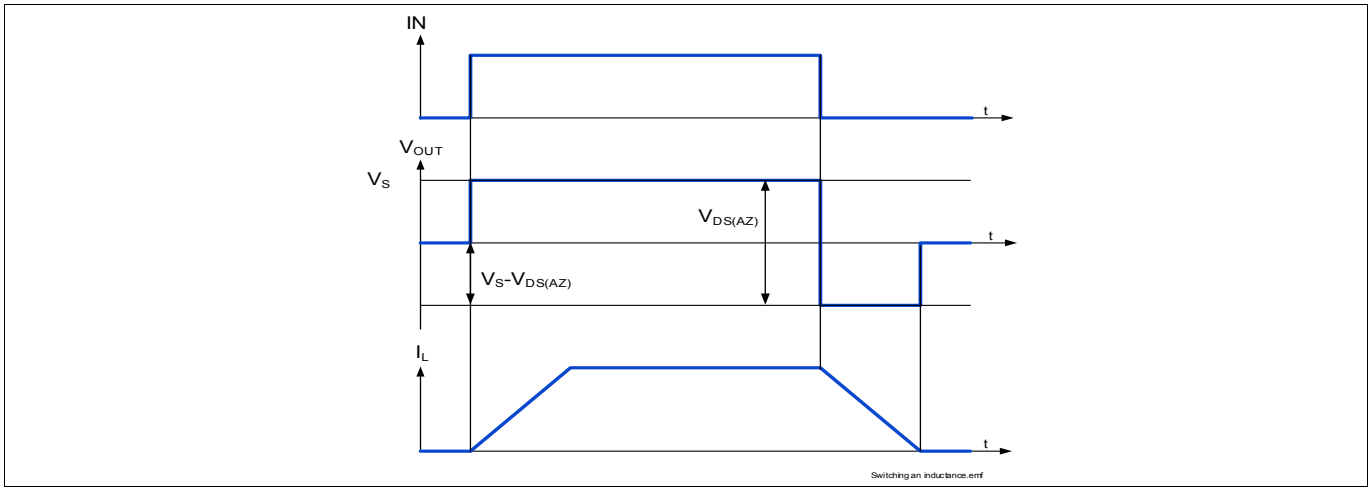


Figure 12 Switching an Inductive Load Timing

5.3.2 Maximum Load Inductance

During demagnetization of inductive loads, energy has to be dissipated in the BTF6070-2EKV. This energy can be calculated with following equation:

$$E = V_{DS(AZ)} \times \frac{L}{R_L} \times \left[\frac{V_S - V_{DS(AZ)}}{R_L} \times \ln\left(1 - \frac{R_L \times I_L}{V_S - V_{DS(AZ)}}\right) + I_L \right] \quad (5.1)$$

Following equation simplifies under the assumption of R_L = 0 Ω.

$$E = \frac{1}{2} \times L \times I^2 \times \left(1 - \frac{V_S}{V_S - V_{DS(AZ)}}\right) \quad (5.2)$$

The energy, which is converted into heat, is limited by the thermal design of the component. See Figure 13 for the maximum allowed energy dissipation as a function of the load current.

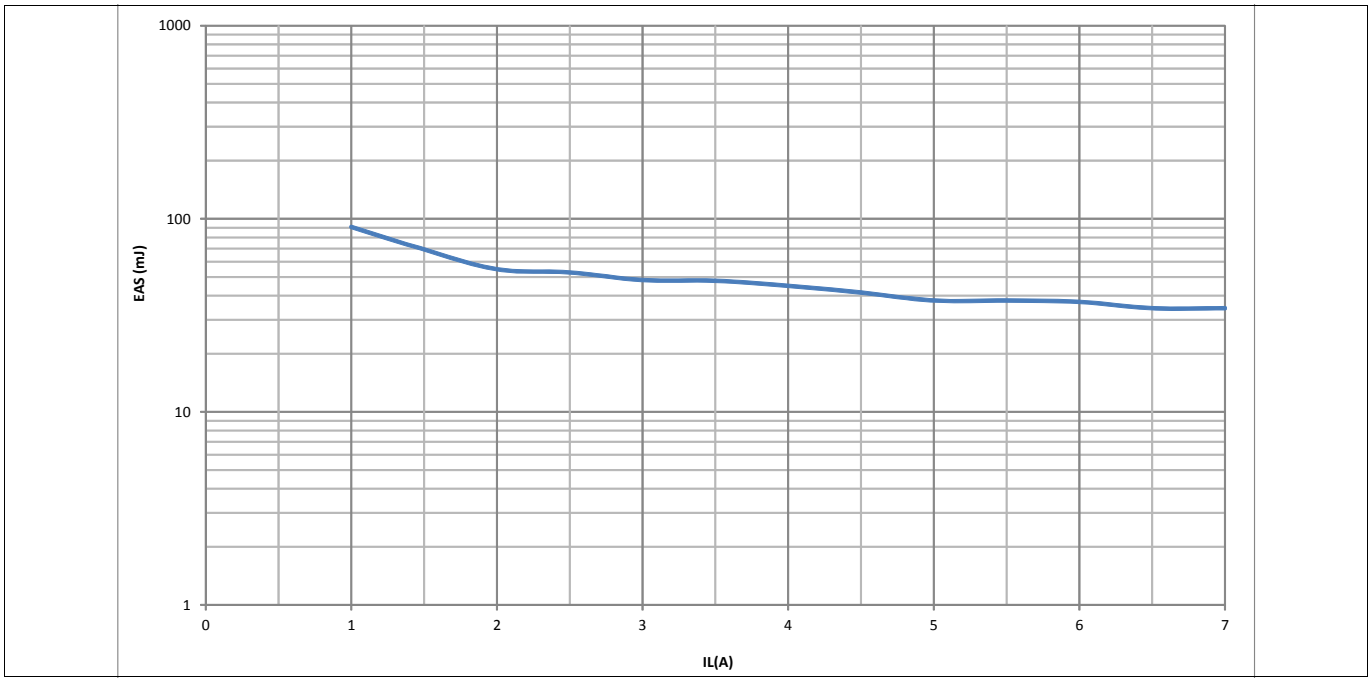


Figure 13 Maximum Energy Dissipation Single Pulse, T_{J_START} = 150 °C

5.4 Inverse Current Capability

In case of inverse current, meaning a voltage V_{INV} at the OUTput higher than the supply voltage V_S, a current I_{INV} will flow from output to V_S pin via the body diode of the power transistor (please refer to Figure 14). The output stage follows the state of the IN pin, except if the IN pin goes from OFF to ON during inverse.In that particular case, the output stage is kept OFF until the inverse current disappears. Nevertheless, the current I_{INV} should not be higher than $I_{L(INV)}$. $I_{L(NV)}$ can be considered as 3 A.
If the channel is OFF, the diagnostic will detect an open load at OFF. If the affected channel is ON, the diagnostic will detect open load at ON (the overtemperature signal is inhibited). At the appearance of V_{INV}, a parasitic diagnostic can be observed. After, the diagnosis is valid and reflects the output state. At V_{INV} vanishing, the diagnosis is valid and reflects the output state. During inverse current, no protection functions are available.

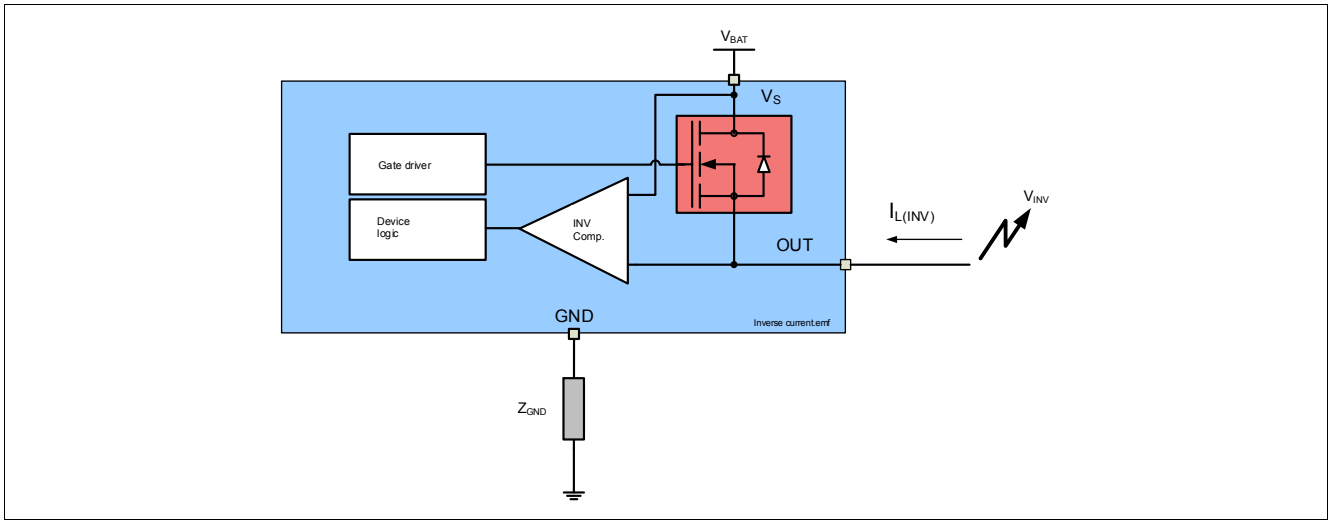


Figure 14 Inverse Current Circuitry

5.5 Electrical Characteristics Power Stage

Table 6 Electrical Characteristics: Power Stage

V_S = 8 V to 36 V, T_J = -40°C to 150°C (unless otherwise specified).
Typical values are given at V_S = 28 V, T_J = 25 °C

Parameter	Symbol	Values			Unit	Note or Test Condition	Number
		Min.	Typ.	Max.			
ON-state resistance per channel	$R_{DS(ON)\_150}$	90	120	135	mΩ	$I_L = I_{L4}$ = 4 A V_{IN} = 4.5 V T_J = 150 °C See Figure 9	P_5.5.1
ON-state resistance per channel	$R_{DS(ON)\_25}$	-	60	-	mΩ	1) T_J = 25 °C	P_5.5.21
Nominal load current One channel active	$I_{L(NOM)1}$	-	3	-	A	1) T_A = 85 °C T_J < 150 °C	P_5.5.2
Nominal load current All channels active	$I_{L(NOM)2}$	-	2.3	-	A		P_5.5.3
Output voltage drop limitation at small load currents	$V_{DS(NL)}$	-	10	22	mV	$I_L = I_{L0}$ = 50 mA	P_5.5.4
Drain to source clamping voltage $V_{DS(AZ)} = (V_S - V_{OUT})$	$V_{DS(AZ)}$	65	70	75	V	I_{DS} = 20 mA See Figure 12	P_5.5.5
Output leakage current per channel $T_J \leq 85$ °C	$I_{L(OFF)}$	-	0.1	0.5	µA	2) V_{IN} floating V_{OUT} = 0 V $T_J \leq 85$°C	P_5.5.6
Output leakage current per channel T_J = 150 °C	$I_{L(OFF)\_150}$	-	1	8	µA	V_{IN} floating V_{OUT} = 0 V T_J = 150 °C	P_5.5.8

Table 6 Electrical Characteristics: Power Stage (cont'd)

V_S = 8 V to 36 V, T_J = -40°C to 150°C (unless otherwise specified).
Typical values are given at V_S = 28 V, T_J = 25 °C

Parameter	Symbol	Values			Unit	Note or Test Condition	Number
		Min.	Typ.	Max.			
Slew rate 30% to 70% V_S	dV/dt_{ON}	1	2.4	4.5	V/µs	R_L = 25 Ω V_S = 28 V See Figure 10	P_5.5.11
Slew rate 70% to 30% V_S	$-dV/dt_{OFF}$	1	2.4	4.5	V/µs		P_5.5.12
Slew rate matching dV/dt_{ON} - dV/dt_{OFF}	$\Delta dV/dt$	-0.5	0	0.5	V/µs		P_5.5.13
Turn-ON time to V_{OUT} = 90% V_S	t_{ON}	5	28	70	µs		P_5.5.14
Turn-OFF time to V_{OUT} = 10% V_S	t_{OFF}	5	28	70	µs		P_5.5.15
Turn-ON / OFF matching t_{OFF} - t_{ON}	Δt_{SW}	-20	5	20	µs		P_5.5.16
Turn-ON time to V_{OUT} = 10% V_S	t_{ON_delay}	-	17	40	µs		P_5.5.17
Turn-OFF time to V_{OUT} = 90% V_S	t_{OFF_delay}	-	17	40	µs		P_5.5.18
Switch ON energy	E_{ON}	-	115	-	µJ	[1] R_L = 25 Ω V_{OUT} = 90% V_S V_S = 36 V	P_5.5.19
Switch OFF energy	E_{OFF}	-	173	-	µJ	[1] R_L = 25 Ω V_{OUT} = 10% V_S V_S = 36 V	P_5.5.20

1) Not subject to production test, specified by design.
2) Test at T_J = -40°C only

6 Protection Functions

The device provides integrated protection functions. These functions are designed to prevent the destruction of the IC from fault conditions described in the data sheet. Fault conditions are considered as “outside” normal operating range. Protection functions are designed for neither continuous nor repetitive operation.

6.1 Loss of Ground Protection

In case of loss of the module ground and the load remains connected to ground, the device protects itself by automatically turning OFF (when it was previously ON) or remains OFF, regardless of the voltage applied on IN pins.

In case of loss of device ground, it’s recommended to use input resistors between the microcontroller and the BTF6070-2EKV to ensure switching OFF of channels.

In case of loss of module or device ground, a current ($I_{OUT(GND)}$) can flow out of the DMOS. Figure 15 sketches the situation.

Z_{GND} is recommended to be a resistor in series to a diode.

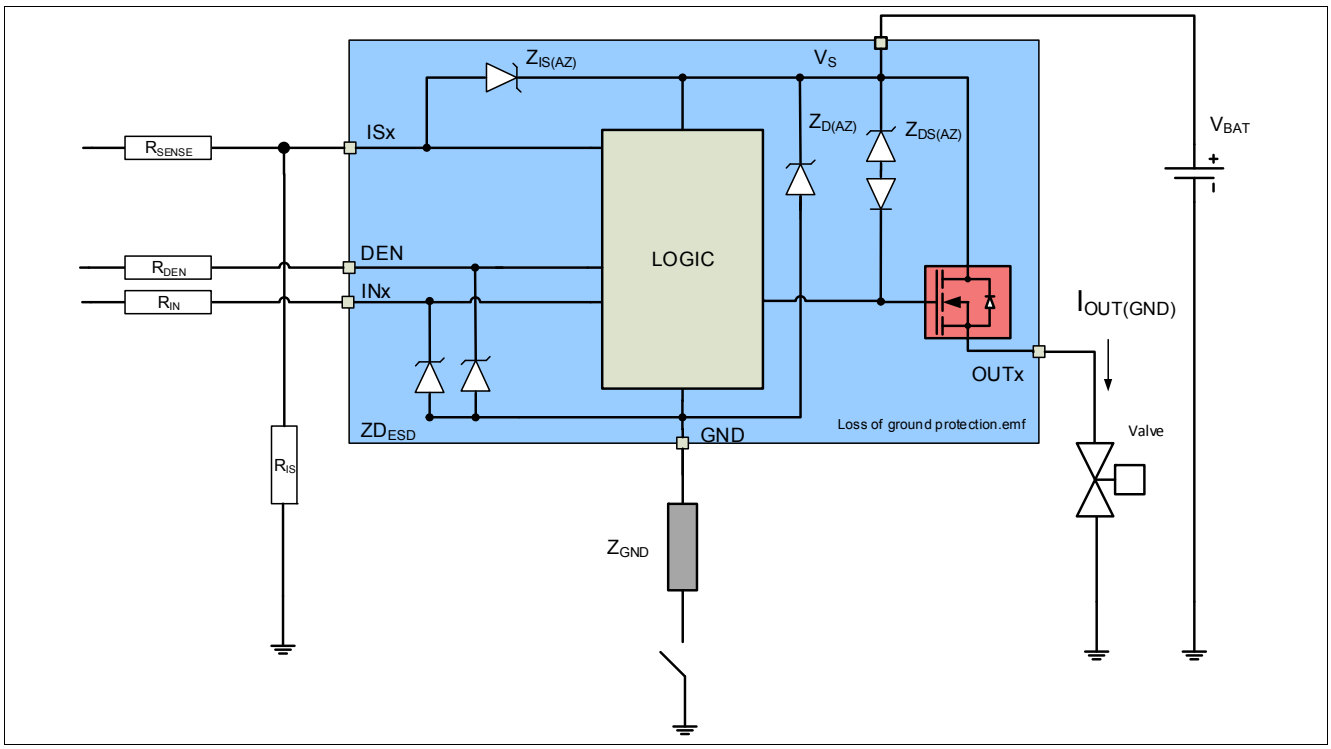


Figure 15 Loss of Ground Protection with External Components

6.2 Undervoltage Protection

Between $V_{S(UV)}$ and $V_{S(OP)}$, the undervoltage mechanism is triggered. $V_{S(OP)}$ represents the minimum voltage where the switching ON and OFF can takes place. $V_{S(UV)}$ represents the minimum voltage the switch can hold ON. If the supply voltage is below the undervoltage mechanism $V_{S(UV)}$, the device is OFF (turns OFF). As soon as the supply voltage is above the undervoltage mechanism $V_{S(OP)}$, then the device can be switched ON. When the switch is ON, protection functions are operational. Nevertheless, the diagnosis is not guaranteed until V_S is in the V_{NOM} range. Figure 16 sketches the undervoltage mechanism.

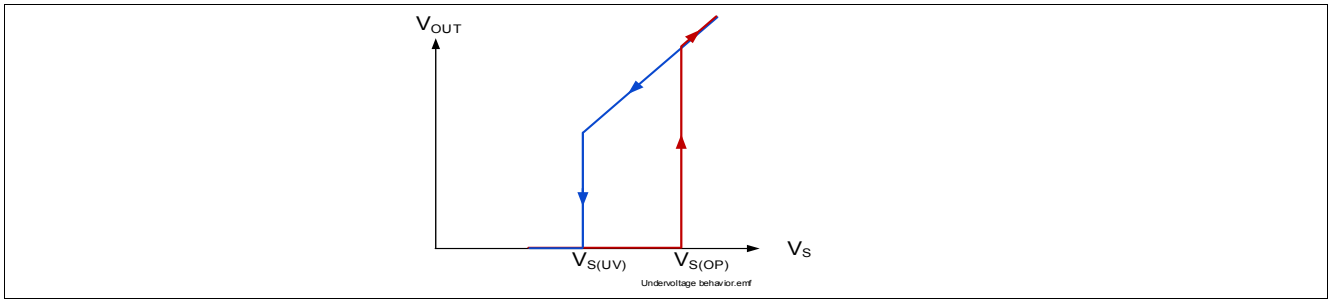


Figure 16 Undervoltage Behavior

6.3 Overvoltage Protection

There is an integrated clamp mechanism for overvoltage protection ($Z_{D(AZ)}$). To guarantee this mechanism operates properly in the application, the current in the Zener diode has to be limited by a ground resistor. Figure 17 shows a typical application to withstand overvoltage issues. In case of supply voltage higher than $V_{S(AZ)}$, the power transistor switches ON and in addition the voltage across the logic section is clamped. As a result, the internal ground potential rises to V_S - $V_{S(AZ)}$. Due to the ESD Zener diodes, the potential at pin INx and DEN rises almost to that potential, depending on the impedance of the connected circuitry. In the case the device was ON, prior to overvoltage, the BTF6070-2EKV remains ON. In the case the BTF6070-2EKV was OFF, prior to overvoltage, the power transistor can be activated. In the case the supply voltage is in above $V_{BAT(SC)}$ and below $V_{DS(AZ)}$, the output transistor is still operational and follows the input. If at least one channel is in the ON state, parameters are no longer guaranteed and lifetime is reduced compared to the nominal supply voltage range. This especially impacts the short circuit robustness, as well as the maximum energy E_{AS} capability. The values for $Z_{IS(A)}$, $Z_{D(A)}$ and $Z_{DS(A)}$ are included in the parameter P_6.6.3. Z_{GND} is recommended to be a resistor in series to a diode.

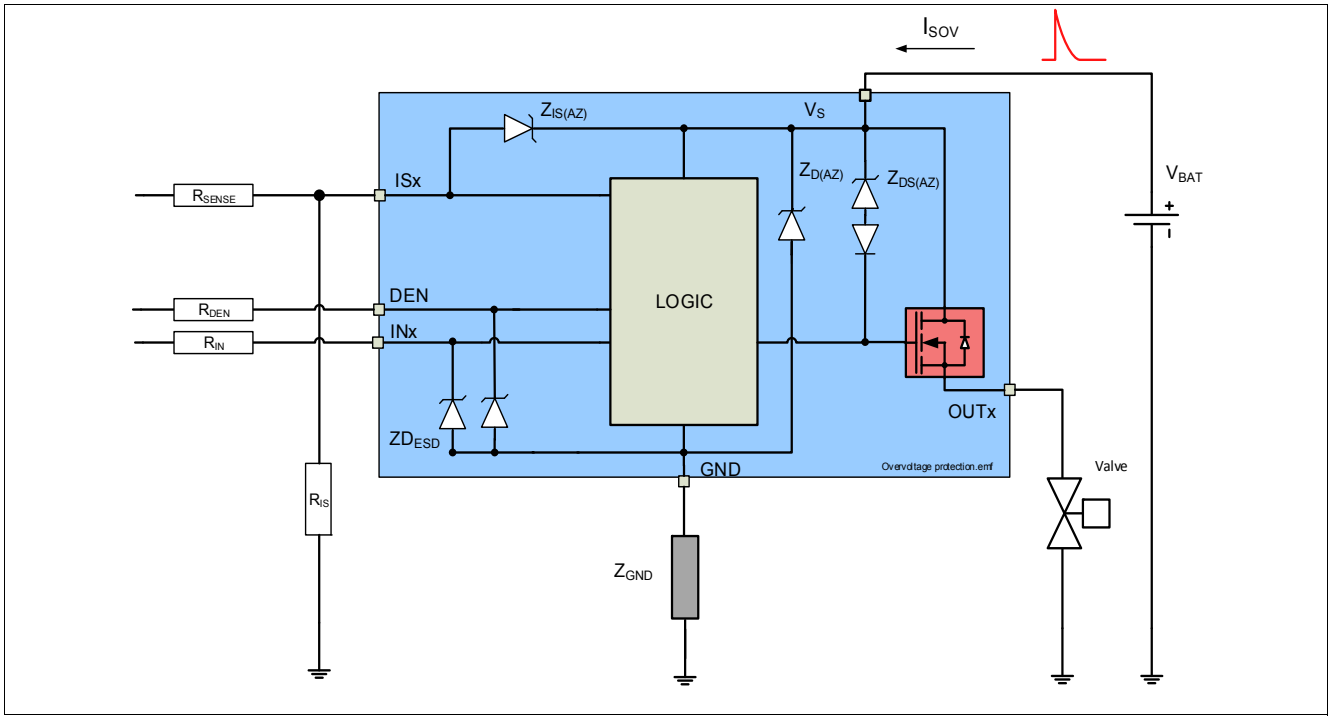


Figure 17 Overvoltage Protection with External Components

6.4 Reverse Polarity Protection

In case of reverse polarity, the intrinsic body diodes of the power DMOS causes power dissipation. The current in this intrinsic body diode is limited by the load itself. Additionally, the current into the ground path and the logic

pins has to be limited to the maximum current described in Chapter 4.1 with an external resistor. Figure 18 shows a typical application. R_{GND} resistor is used to limit the current in the Zener protection of the device. Resistors R_{DEN}, and R_{IN} are used to limit the current in the logic of the device and in the ESD protection stage. R_{SENSE} is used to limit the current in the sense transistor which behaves as a diode. The recommended value for R_{DEN} = R_{IN} = 10 kΩ. Z_{GND} is recommended to be a resistor in series to a diode.

During reverse polarity, no protection functions are available.

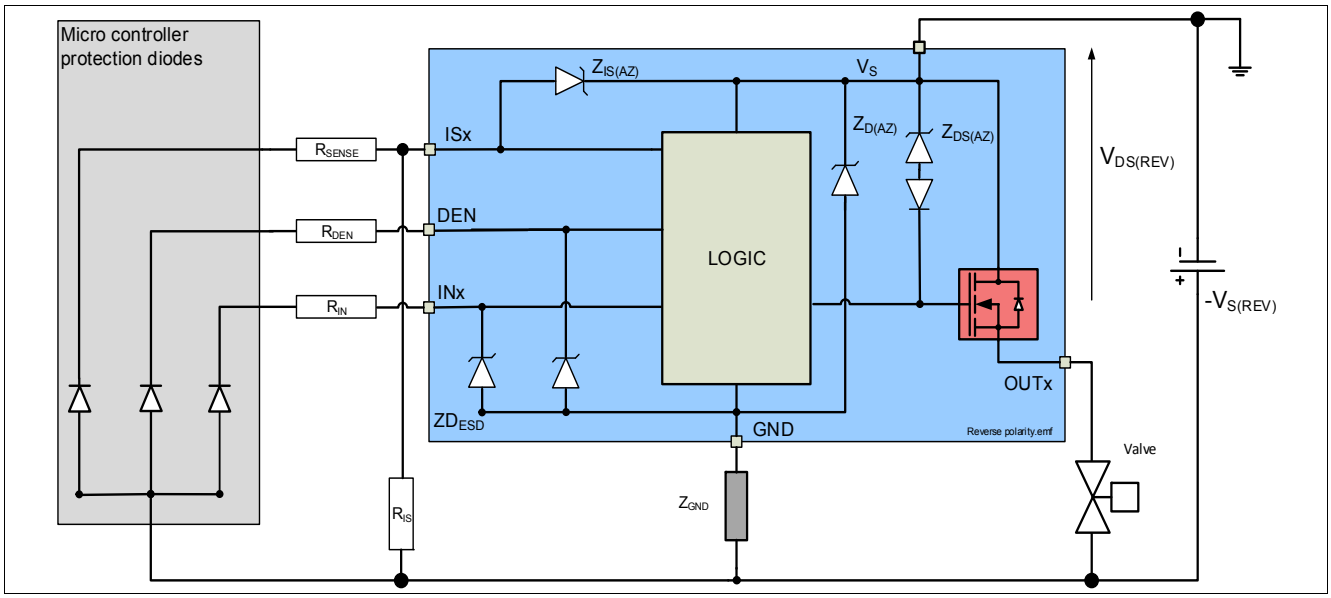


Figure 18 Reverse Polarity Protection with External Components

6.5 Overload Protection

In case of overload, such as high inrush of cold lamp filament, or short circuit to ground, the BTF6070-2EKV offers several protection mechanisms.

6.5.1 Current Limitation

At first step, the instantaneous power in the switch is maintained at a safe value by limiting the current to the maximum current allowed in the switch $I_{L(SC)}$. During this time, the DMOS temperature is increasing, which affects the current flowing in the DMOS.

6.5.2 Temperature Limitation in the Power DMOS

Each channel incorporates both an absolute ($T_{J(SC)}$) and a dynamic ($T_{J(SW)}$) temperature sensor. Activation of either sensor will cause an overheated channel to switch OFF to prevent destruction. Any protective switch OFF latches the output until the temperature has reached an acceptable value. Figure 19 gives a sketch of the situation.

No retry strategy is implemented such that when the DMOS temperature has cooled down enough, the switch is switched ON again. Only the IN pin signal toggling can re-activate the power stage (latch behavior).

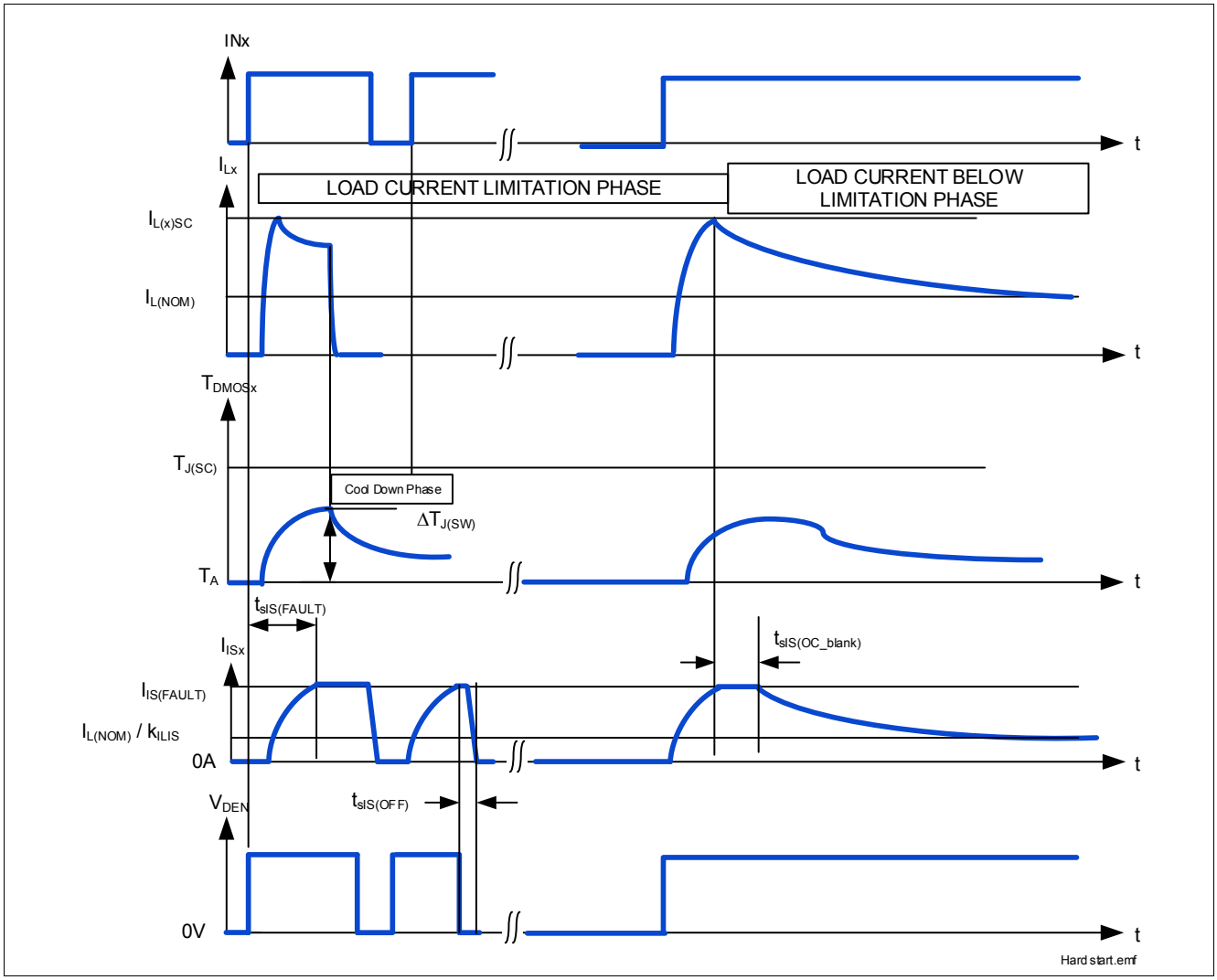


Figure 19 Overload Protection

Note: For better understanding, the time scale is not linear. The real timing of this drawing is application dependant and cannot be described.

6.6 Electrical Characteristics for the Protection Functions

Table 7 Electrical Characteristics: Protection

V_S = 8 V to 36 V, T_J = -40°C to 150°C (unless otherwise specified).
Typical values are given at V_S = 28 V, T_J = 25 °C

Parameter	Symbol	Values			Unit	Note or Test Condition	Number
		Min.	Typ.	Max.			
Loss of Ground							
Output leakage current while GND disconnected	$I_{OUT(GND)}$	-	0.1	-	µA	[1)2)] V_S = 45 V See Figure 15	P_6.6.1
Reverse Polarity							
Drain source diode voltage during reverse polarity	$V_{DS(REV)}$	400	650	700	mV	I_L = - 2 A T_J = 150 °C See Figure 18	P_6.6.2
Overvoltage							
Overvoltage protection	$V_{S(AZ)}$	65	70	75	V	I_{SOV} = 5 mA See Figure 17	P_6.6.3
Overload Condition							
Load current limitation	$I_{L5(SC)}$	9	11	14	A	[3)] V_{DS} = 10 V See Figure 19	P_6.6.4
Dynamic temperature increase while switching	$\Delta T_{J(SW)}$	-	80	-	K	[4) 3)] See Figure 19	P_6.6.8
Thermal shutdown temperature	$T_{J(SC)}$	150	170 [4)]	200 [4)]	°C	[5)] See Figure 19	P_6.6.10
Thermal shutdown hysteresis	$\Delta T_{J(SC)}$	-	30	-	K	[2)] See Figure 19	P_6.6.11

1) All pins are disconnected except V_S and OUT.
2) Not Subject to production test, specified by design
3) Test at T_J = -40°C only
4) Functional test only
5) Test at T_J = +150°C only

7 Diagnostic Functions

For diagnosis purpose, the BTF6070-2EKV provides a combination of digital and analog signals at the IS Pins (IS0 and IS1). These signals are called SENSE. In case the diagnostic is disabled via DEN, pins IS become high impedance. In case DEN is activated, the sense current of both channels is enabled. Table 8 gives the truth table.

Table 8 Diagnostic Truth Table

DEN	IS0	IS1
0	Z	Z
1	Sense output 0 IIS(0)	Sense output 1 IIS(1)

7.1 IS Pins

The BTF6070-2EKV provides a sense signal called I_{IS} at pins ISx. As long as no “hard” failure mode occurs (short circuit to GND / current limitation / overtemperature / excessive dynamic temperature increase or open load at OFF) a proportional signal to the load current (ratio $k_{ILIS} = I_L / I_{IS}$) is provided. The complete IS pins and diagnostic mechanism is described on Figure 20. The accuracy of the sense current depends on temperature and load current. Due to the ESD protection, in connection to V_S, it is not recommended to share the IS pins with other devices if these devices are using another battery feed. The consequence is that the unsupplied device would be fed via the IS pin of the supplied device.

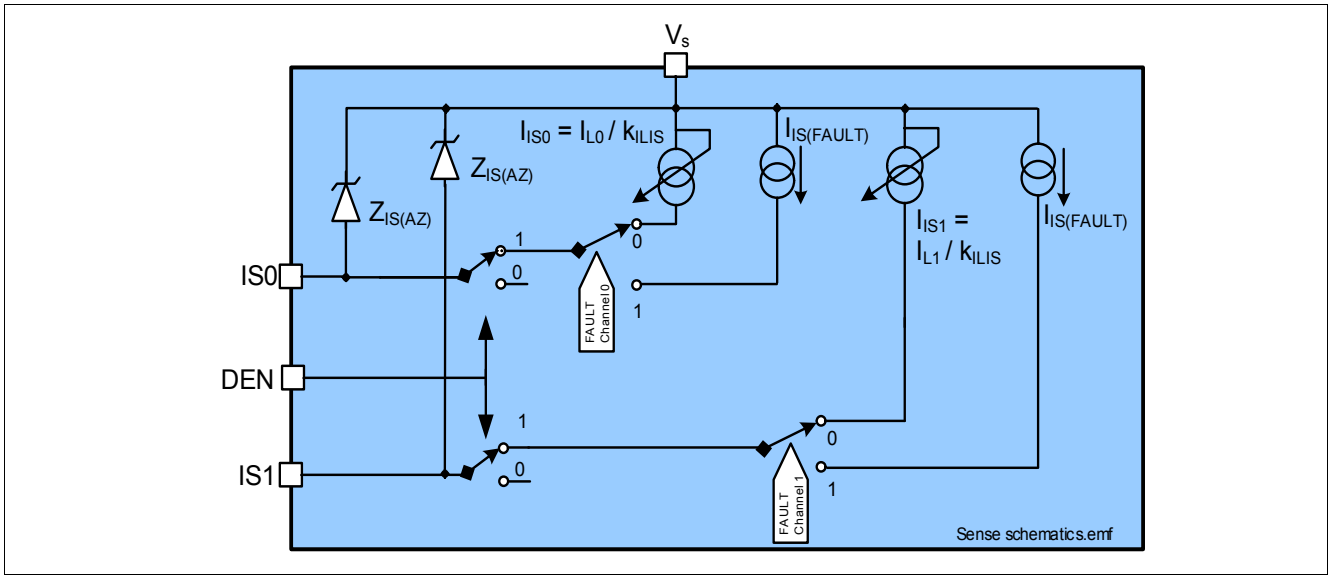


Figure 20 Diagnostic Block Diagram